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J402-VB Datasheet

P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)		
- 60	0.019 at V _{GS} = - 10 V	- 80	76 nC		
- 60	0.025 at V _{GS} = - 4.5 V	- 70	10110		

FEATURES

- TrenchFET[®] Power MOSFET
- 100 % UIS Tested

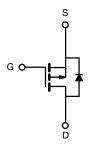
APPLICATIONS

Load Switch





D²PAK (TO-263)



P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 60	v		
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		- 80 ^a		
Continuous Drain Current (T = $150 ^{\circ}$ C)	T _C = 70 °C		- 70		
Continuous Drain Current ($T_J = 150 \ ^{\circ}C$)	T _A = 25 °C	I _D	9.2 ^b	А	
	T _A = 70 °C		- 8.1 ^b	~	
Pulsed Drain Current		I _{DM}	- 150	1	
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	- 45]	
Single Pulse Avalanche Energy	L = 0.1 mm	E _{AS}	101	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	L.	69 ^a	А	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.1 ^b	A .	
	T _C = 25 °C		104.2 ^a		
Maximum Davian Diasia atian	T _C = 70 °C		66.7 ^a	14/	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.1 ^b	W	
	T _A = 70 °C		2 ^b		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	Steady State	R _{thJA}	33	40	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.98	1.2	C/VV	

Notes:

a. Based on T_C = 25 °C.

b. Surface mounted on 1" x 1" FR4 board.

$V_{GS(th)}$ Temperature Coefficient $\Delta V_{GS(th)}/T_J$ -5.2 Gate-Source Threshold Voltage $V_{GS(th)}$ $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ -1 -3 V Gate-Source Leakage I_{GSS} $V_{DS} = 0 \ V$, $V_{GS} = \pm 20 \ V$ ± 100 nA V_{DS} = -60 V, $V_{GS} = 0 \ V$	SPECIFICATIONS (T _J = 25 $^{\circ}$ C,	unless othe	erwise noted)					
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Static					-		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source Breakdown Voltage		$V_{GS} = 0 V$, $I_{D} = -250 \mu A$	- 60			V	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = - 250 uA		68		mV/°C	
	V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	η μη		- 5.2			
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1		- 3	V	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Source Leakage		$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Zero Gate Voltage Drain Current		$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		DSS	$V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			- 10	- μΑ	
$\begin{array}{ c c c c c c c c c c c c c c c c c c c$	On-State Drain Current ^a	I _{D(on)}	V _{DS} = - 5 V, V _{GS} = - 10 V	- 120			A	
$ \begin{array}{ c c c c c c c } \hline V_{GS} = -4.5 \ V, \ V_{DS} = -20 \ A & 0.025 $		Р	V _{GS} = - 10 V, I _D = - 30 A		0.019			
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 20 A		0.025			
$ \begin{array}{ c c c c c c c } \hline Input Capacitance & C_{iss} \\ \hline Output Capacitance & C_{oss} \\ \hline Output Capacitance & C_{rss} \\ \hline Output Cap$	Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 50 A	20			S	
$ \begin{array}{c c c c c c c c } \hline Output Capacitance & C_{oss} & V_{DS} = -25 \ V, \ V_{GS} = 0 \ V, \ f = 1 \ MHz & 390 & pF \\ \hline \hline \ Reverse Transfer Capacitance & C_{rss} & V_{DS} = -30 \ V, \ V_{GS} = -10 \ V, \ I_D = -55 \ A & 76 & pF \\ \hline \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \$	Dynamic ^b					-		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Input Capacitance	C _{iss}			3500		pF	
$ \begin{array}{c c c c c c c c c } \hline Total Gate Charge & Q_{g} & V_{DS} = -30 \ V, \ V_{GS} = -10 \ V, \ I_{D} = -55 \ A & 76 & 38 & 0 \\ \hline Gate-Source Charge & Q_{gd} & V_{DS} = -30 \ V, \ V_{GS} = -4.5 \ V, \ I_{D} = -55 \ A & 16 & 0 \\ \hline Gate Resistance & R_{g} & f = 1 \ MHz & 5.2 & \Omega \\ \hline Turn-On Delay Time & t_{d(on)} & V_{DD} = -2 \ V, \ R_{L} = 2 \ \Omega & 10 & 15 \\ \hline Turn-Off Delay Time & t_{f} & V_{DD} = -2 \ V, \ R_{L} = 2 \ \Omega & 7 & 15 \\ \hline Turn-Off Delay Time & t_{f} & V_{DD} = -10 \ A, \ V_{GEN} = -10 \ V, \ R_{g} = 1 \ \Omega & 40 & 60 \\ \hline \hline Drain-Source Body Diode Characteristics & & & & & & & & & & & & & & & & & & &$	Output Capacitance	C _{oss}	$V_{DS} = -25 V$, $V_{GS} = 0 V$, f = 1 MHz		390			
$ \begin{array}{ c c c c c c } \hline \mbox{trian} Gate Charge & G_{g} & & 38 & & & & & & & & & & & & & & & & $	Reverse Transfer Capacitance	C _{rss}]		290			
$ \begin{array}{ c c c c c } \hline \ & \ & \ & \ & \ & \ & \ & \ & \ & \$	Total Gate Charge		$V_{DS} = -30$ V, $V_{GS} = -10$ V, $I_{D} = -55$ A		76			
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Iotal Gale Charge				38		nC	
$ \begin{array}{c c c c c c c c } \hline Gate Resistance & R_g & f = 1 \ MHz & 5.2 & \Omega \\ \hline Turn-On Delay Time & t_d(on) & & & & & & \\ \hline Rise Time & t_r & & & & & & & & & \\ \hline Turn-Off Delay Time & t_d(off) & & & & & & & & & & \\ \hline Turn-Off Delay Time & t_d(off) & & & & & & & & & & & \\ \hline Fall Time & t_f & & & & & & & & & & & & & \\ \hline Pain-Source Body Diode Characteristics & & & & & & & & & & & & \\ \hline Drain-Source Drain Diode Current & I_S & T_C = 25 \ ^C & & & & & & & & & & & & \\ \hline Pulse Diode Forward Current^a & I_{SM} & & & & & & & & & & & & & & \\ \hline Body Diode Voltage & V_{SD} & I_S = -30 \ A & & & & & & & & & & & & & & & & \\ \hline Body Diode Reverse Recovery Time & t_{rr} & & & & & & & & & & & & & & & & & & $	Gate-Source Charge	Q _{gs}	$V_{\rm DS}$ = - 30 V, $V_{\rm GS}$ = - 4.5 V, $I_{\rm D}$ = - 55 A		16		ne	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate-Drain Charge	Q _{gd}			19			
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate Resistance	Rg	f = 1 MHz		5.2		Ω	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Turn-On Delay Time	t _{d(on)}			10	15		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Rise Time	t _r	V_{DD} = - 2 V, R_L = 2 Ω		7	15	ns	
Drain-Source Body Diode CharacteristicsContinuous Source-Drain Diode CurrentIs $T_C = 25 \ ^{\circ}C$ - 69APulse Diode Forward Current ^a I _{SM} - 150- 150ABody Diode Voltage V_{SD} $I_S = -30 \ A$ - 1- 1.5VBody Diode Reverse Recovery Time t_{rr} 4568nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = -50 \ A, di/dt = 100 \ A/\mus, T_J = 25 \ ^{\circ}C$ 59120nCReverse Recovery Fall Time t_a rs rs rs rs	Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 10 V, R_g = 1 Ω		70	110		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Fall Time	t _f]		40	60		
Pulse Diode Forward Current ^a I SMI SM- 150ABody Diode Voltage V_{SD} $I_S = -30 \text{ A}$ - 1- 1.5VBody Diode Reverse Recovery Time t_{rr} 4568nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = -50 \text{ A}$, di/dt = 100 A/µs, $T_J = 25 \text{ °C}$ 59120nCReverse Recovery Fall Time t_a t_a t_a t_a t_a t_a t_a	Drain-Source Body Diode Characteristic	s	•			•		
Pulse Diode Forward Current ^a I SMI SM- 150Body Diode Voltage V_{SD} $I_S = -30 \text{ A}$ - 1- 1.5VBody Diode Reverse Recovery Time t_{rr} 4568nsBody Diode Reverse Recovery Charge Q_{rr} $I_F = -50 \text{ A}$, di/dt = 100 A/µs, $T_J = 25 \text{ °C}$ 59120nCReverse Recovery Fall Time t_a r_a r_a r_a r_a r_a	Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			- 69	A	
Body Diode Reverse Recovery Time t_{rr} 4568nsBody Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a	Pulse Diode Forward Current ^a	I _{SM}				- 150		
Body Diode Reverse Recovery Charge Q_{rr} $I_F = -50 \text{ A}, di/dt = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$ 59120nCReverse Recovery Fall Time t_a	Body Diode Voltage	V _{SD}	I _S = - 30 A		- 1	- 1.5	V	
Reverse Recovery Fall Time t_a $I_F = -50$ A, divid = 100 A/µs, $T_J = 25$ C 29 ns.	Body Diode Reverse Recovery Time	t _{rr}			45	68	ns	
Reverse Recovery Fall Time t_a $I_F = -50$ A, divid = 100 A/µs, $T_J = 25$ C 29 ns.	Body Diode Reverse Recovery Charge	Q _{rr}			59	120	nC	
Reverse Recovery Rise Time t _b ns	Reverse Recovery Fall Time		1 = -50 A, areal = 100 A/ as 1 = 25 C		29		- ns	
	Reverse Recovery Rise Time	t _b	1		16	1		

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

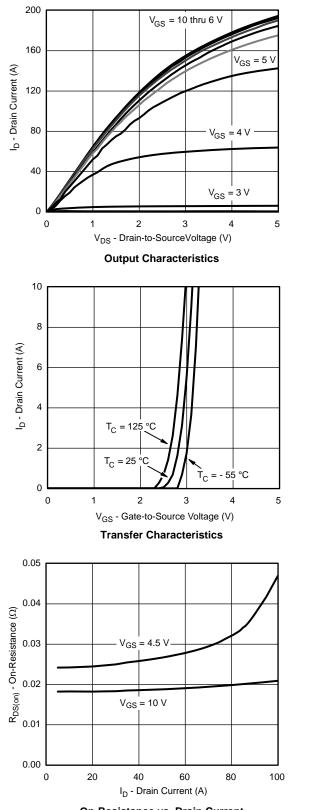
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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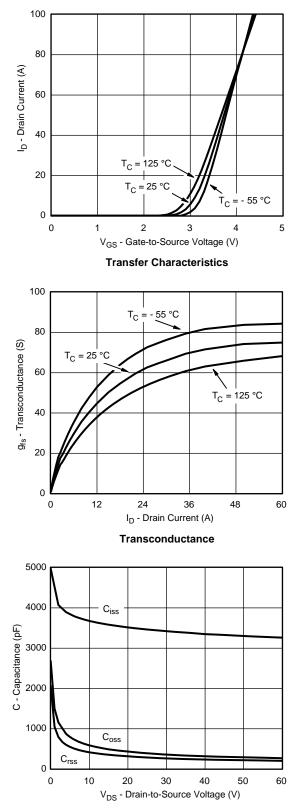
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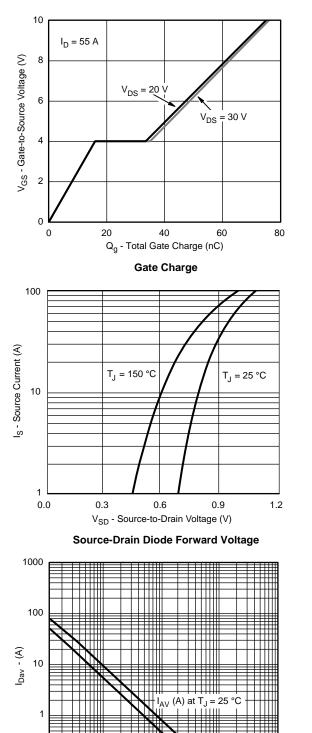


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

On-Resistance vs. Drain Current







TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

 $\label{eq:Tin-s} T_{\text{in}} \text{-} (s)$ Single Pulse Avalanche Current Capability vs. Time

0.01

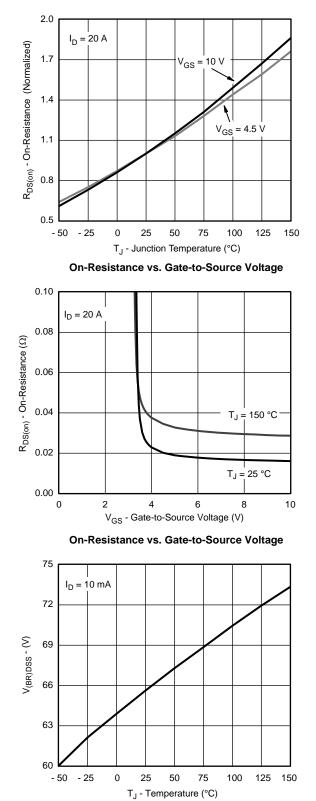
0.1

1

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 I_{AV} (A) at T_{J} = 150

0.001

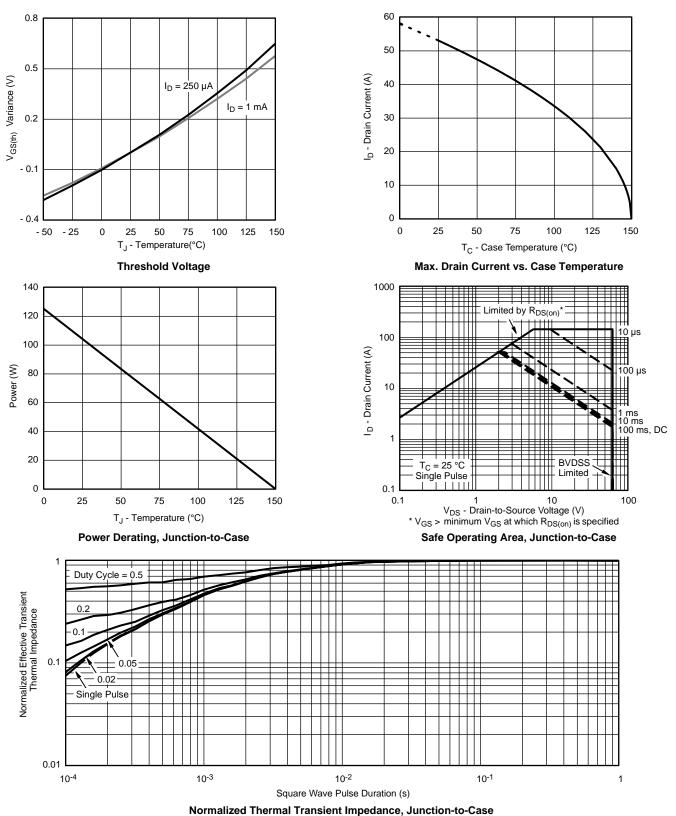


Drain-Source Breakdown Voltage vs. Junction Temperature

0.1

0.0001

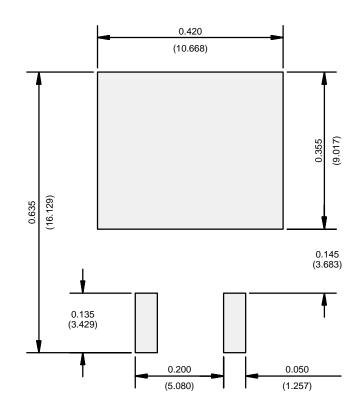




TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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